


<b>Search Notes</b>  	<b>Application/Control No.</b>  10614997	<b>Applicant(s)/Patent Under Reexamination</b>  BURKE ET AL.
	<b>Examiner</b>  PHUNG M CHUNG	<b>Art Unit</b>  2117

SEARCHED			
Class	Subclass	Date	Examiner
714	724-725,733-734,10,11,30,38,742,740,776	5/26/08	pmc
702	118	5/26/08	pmc
716	4	5/26/08	pmc

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner